TEST LOG



Article number:	112020WS004	Sprach	ne Language ODE	⊙en Ofr	Onl Oes Opl	
Internal number:		Serial number:		Date:	21.12.2021	
Device status:			Bemerkungen / Remarks:			
As good as new ur	nused					
Damaged (light) te	chnically inspected					
Damaged (dents/scratches) technically checked						
Signs of wear (light) technically checked						
Traces of use techr	ically checked					
Product Specific Infor	rmation					
VDE test conducted:	YES	NO	■ NO	T NECESSARY		
Device complete:	YES	NO				
All functions tested:	YES	NO				
Device cleaned:	YES	NO				
Packaging:						
Original packaging						
Original packaging	(damaged)					

Substitute packaging

Picture 1



TEST LOG | A-LAGER



Picture 2



Picture 3



TEST LOG | A-LAGER

Picture 4



Picture 5



Picture 6



